

IN THE CLAIMS

1. – 3. (Canceled)

4. (Currently Amended) ~~The plasma processing apparatus as claimed in claim 1,~~  
~~A plasma processing apparatus for applying a process to a substrate to be processed,~~  
~~the plasma processing apparatus comprising:~~

a chamber of which interior can be depressurized,  
a gas supply system constructed and arranged to supply a gas to the chamber and an  
exhaust system configured and arranged to exhaust the gas supplied to the chamber and to  
depressurize the chamber;

a part of a wall constituting the chamber being a flat plate dielectric material plate  
formed of a material which passes a microwave therethrough substantially without a loss;

a flat plate dielectric material shower plate, which is formed of a material which  
passes a microwave therethrough substantially without a loss, being provided between the  
dielectric material plate and plasma excited in the chamber;

a plurality of gas discharge holes being formed in the dielectric material shower plate  
so that at least a part of the gas supplied by the gas supply system is discharged through the  
plurality of gas discharge holes through a gap between the dielectric material plate and the  
dielectric material shower plate;

a flat plate slot antenna being provided on an outer side of the chamber with the  
dielectric material plate interposed therebetween so as to supply a microwave for exciting  
plasma through the dielectric material plate;

an electrode being provided on an inner side of the chamber so as to hold the substrate  
to be processed;

a lattice-like shower head provided between the dielectric material shower plate and  
the substrate to be processed so as to discharge a gas, which has a composition different from  
that of the gas discharged from the dielectric material shower plate, to a side of the substrate  
to be processed; and

at least a part of the gas discharged from the dielectric material shower plate flows to the side of the substrate to be processed by being passed through an opening part of the lattice-like shower head,

wherein said lattice-like shower head is formed of a metal pipe comprising a plurality of gas discharge holes configured and arranged such that a normal to each of said holes is oblique to the surface of the substrate, and each of said holes is formed on a curved surface of said metal pipe, and

wherein said dielectric material shower plate and said lattice-like shower head are arranged substantially parallel to each other, and a distance therebetween is substantially equal to a multiple of a quarter of a wavelength of said microwave in a vacuum.

5. (Currently Amended) The plasma processing apparatus as claimed in claim 4 one of claims 1 to 4, wherein said dielectric material plate and said dielectric material shower plate are arranged substantially parallel to each other, and a distance between a surface of said dielectric material plate facing said slot antenna and a surface of the dielectric material shower plate facing said substrate to be processed is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

6. (Previously Presented) The plasma processing apparatus as claimed in claim 5, wherein said slot antenna and said dielectric material plate are arranged substantially parallel to each other, and a distance therebetween is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

7. (Currently Amended) The plasma processing apparatus as claimed in claim 4 one of claims 1 to 4, wherein a thickness of said dielectric material shower plate is an integral multiple of a half of a wavelength of said microwave in a corresponding part.

8. (Previously Presented) The plasma processing apparatus as claimed in claim 7, wherein said slot antenna and said dielectric material plate are arranged substantially parallel to each other, and a distance therebetween is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

9. – 12. (Canceled)

13. (Previously Presented) A plasma processing apparatus for applying a process to a substrate to be processed, the plasma processing apparatus comprising:
- a chamber of which interior can be depressurized;
  - a gas supply system constructed and arranged to supply a gas to the chamber and an exhaust system configured and arranged to exhaust the gas supplied to the chamber and to depressurize the chamber;
  - a part of a wall constituting the chamber being a flat plate dielectric material plate formed of a material which passes a microwave therethrough substantially without a loss;
  - a flat plate dielectric material shower plate, which is formed of a material which passes a microwave therethrough substantially without a loss, being provided between the dielectric material plate and plasma excited in the chamber;
  - a plurality of gas discharge holes being formed in the dielectric material shower plate so that at least a part of the gas supplied by the gas supply system is discharged through the plurality of gas discharge holes through a gap between the dielectric material plate and the dielectric material shower plate;
  - a flat plate slot antenna being provided on an outer side of the chamber with the dielectric material plate interposed therebetween so as to supply a microwave for exciting plasma through the dielectric material plate;
  - an electrode being provided on an inner side of the chamber so as to hold the substrate to be processed,
- wherein the slot antenna, the dielectric material plate and the dielectric material shower plate are arranged substantially parallel to each, and a distance between a surface of the dielectric material plate facing said slot antenna and a surface of said dielectric material shower plate facing said substrate to be processed is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

14. (Previously Presented) The plasma processing apparatus as claimed in claim 13, wherein a thickness of said dielectric material shower plate is an integral multiple of a half of a wavelength of said microwave in a corresponding part.

15. (Previously Presented) The plasma processing apparatus as claimed in claim 13 or 14, wherein a distance between said slot antenna and said dielectric material plate is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

16. (Previously Presented) A plasma processing apparatus for applying a process to a substrate to be processed, the plasma processing apparatus comprising:

a chamber of which interior can be depressurized,

a gas supply system constructed and arranged to supply a gas to the chamber and an exhaust system constructed and arranged to exhaust the gas supplied to the chamber and to depressurize the chamber;

a part of a wall constituting the chamber being a flat plate dielectric material plate formed of a material which passes a microwave therethrough substantially without a loss;

a flat plate dielectric material shower plate, which is formed of a material which passes a microwave therethrough substantially without a loss, being provided between the dielectric material plate and plasma excited in the chamber;

a plurality of gas discharge holes being formed in the dielectric material shower plate so that at least a part of the gas supplied by the gas supply system is discharged through the plurality of gas discharge holes through a gap between the dielectric material plate and the dielectric material shower plate;

a flat plate slot antenna being provided on an outer side of the chamber with the dielectric material plate interposed therebetween so as to supply a microwave for exciting plasma through the dielectric material plate;

an electrode being provided on an inner side of the chamber so as to hold the substrate to be processed;

a lattice-like shower head provided between the dielectric material shower plate and the substrate to be processed so as to discharge a gas, which has a composition different from that of the gas discharged from the dielectric material shower plate, to a side of the substrate to be processed; and

at least a part of the gas discharged from the dielectric material shower plate flows to the side of the substrate to be processed by being passed through an opening part of the lattice-like shower head,

wherein said dielectric material shower plate and said lattice-like shower head are arranged substantially parallel to each other, and a distance therebetween is substantially equal to a multiple of a quarter of a wavelength of said microwave in a vacuum.

17. (Previously Presented) A plasma processing apparatus for applying a process to a substrate to be processed, the plasma processing apparatus comprising:

a chamber of which interior can be depressurized,

a gas supply system constructed and arranged to supply a gas to the chamber and an exhaust system constructed and arranged to exhaust the gas supplied to the chamber and to depressurize the chamber;

a part of a wall constituting the chamber being a flat plate dielectric material plate formed of a material which passes a microwave therethrough substantially without a loss;

a flat plate dielectric material shower plate, which is formed of a material which passes a microwave therethrough substantially without a loss, being provided between the dielectric material plate and plasma excited in the chamber;

a plurality of gas discharge holes being formed in the dielectric material shower plate so that at least a part of the gas supplied by the gas supply system is discharged through the plurality of gas discharge holes through a gap between the dielectric material plate and the dielectric material shower plate;

a flat plate slot antenna being provided on an outer side of the chamber with the dielectric material plate interposed therebetween so as to supply a microwave for exciting plasma through the dielectric material plate;

an electrode being provided on an inner side of the chamber so as to hold the substrate to be processed;

a lattice-like shower head provided between the dielectric material shower plate and the substrate to be processed so as to discharge a gas, which has a composition different from that of the gas discharged from the dielectric material shower plate, to a side of the substrate to be processed; and

at least a part of the gas discharged from the dielectric material shower plate flows to the side of the substrate to be processed by being passed through an opening part of the lattice-like shower head,

wherein said dielectric material plate and said dielectric material shower plate are arranged substantially parallel to each other, and a distance between a surface of said dielectric material plate facing said slot antenna and a surface of the dielectric material shower plate facing said substrate to be processed is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.

18. (Previously Presented) The plasma processing apparatus as claimed in claim 17, wherein said slot antenna and said dielectric material plate are arranged substantially parallel to each other, and a distance therebetween is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.
19. (Previously Presented) The plasma processing apparatus as claimed in claim 16, wherein a thickness of said dielectric material shower plate is an integral multiple of a half of a wavelength of said microwave in a corresponding part.
20. (Previously Presented) The plasma processing apparatus as claimed in claim 19, wherein said slot antenna and said dielectric material plate are arranged substantially parallel to each other, and a distance therebetween is substantially equal to an odd multiple of a quarter of a wavelength of said microwave in a corresponding part.
21. – 23. (Canceled)